

# Search Notes



Application/Control No.

10/667,004

Examiner

Frank W. Lu

Applicant(s)/Patent under Reexamination

CHAN ET AL.

Art Unit

1634

## SEARCHED

Class	Subclass	Date	Examiner
435	6 7.1 9.1	5/12/2006	W
	183		
	283.1		
	287.1		
	287.2		
436	94		
	501		
536	23.1 24.3		
	24.33		
	25.3		
530	300		
	350		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

STN	DATE	EXMR
East (see attached file)	5/12/2006	W